

Notice of References Cited	Application/Control No. 10/767,794		Applicant(s)/Patent Under Reexamination BILLHARTZ ET AL.	
	Examiner <i>K. Afshar</i> Kamran Afshar, 571-272-7796		Art Unit 2681	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0266348 A1	12-2004	Deshpande et al.	455/041.2
*	B	US-6,680,923 B1	01-2004	Leon, Robert	370/328
*	C	US-2003/0162550 A1	08-2003	Kuwahara et al.	455/456
*	D	US-6,865,394 B2	03-2005	Ogino et al.	455/456.1
*	E	US-2004/0203889 A1	10-2004	Karaoguz, Jeyhan	455/456.1
*	F	US-2003/0191604 A1	10-2003	Kuwahara et al.	702/150
*	G	US-2004/0081139 A1	04-2004	Beckmann et al.	370/352
*	H	US-2004/0110514 A1	06-2004	Kim et al.	455/456.1
*	I	US-2003/0182052 A1	09-2003	DeLorme et al.	701/201
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Q					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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